


<b>Search Notes</b>  	<b>Application/Control No.</b>  10828878	<b>Applicant(s)/Patent Under Reexamination</b>  UCHIDA ET AL.
	<b>Examiner</b>  Jonathan R Beckley	<b>Art Unit</b>  4178

SEARCHED			
Class	Subclass	Date	Examiner
358	1.18,1.12,408,403,3.06,1.15,1.14,1.1	11/15/2007	JB
382	224,257,226,112,173	11/15/2007	JB
283	67	11/15/2007	JB
386	52	11/15/2007	JB
345	581,629,619,419,611,589	11/15/2007	JB
709	203	11/15/2007	JB
101	40,483	11/15/2007	JB
715	704,509,839,517,762	11/15/2007	JB
402	79	11/15/2007	JB
348	586	11/15/2007	JB
707	104.1	11/15/2007	JB
358	1.18,1.12,408,403,3.06,1.15,1.14,1.1	6/3/2008	JB
382	224,257,226,112,173	6/3/2008	JB
345	581,629,619,419,611,589	6/3/2008	JB
715	704,509,839,517,762	6/3/2008	JB
358	1.18,1.12,408,403,3.06,1.15,1.14,1.1	2/2/2009	JB
382	224,257,226,112,173	2/2/2009	JB
345	581,629,619,419,611,589	2/2/2009	JB
715	704,509,839,517,762	2/2/2009	JB

SEARCH NOTES		
Search Notes	Date	Examiner
EAST	11/15/2007	JB
EAST	11/14/2007	JB
EAST	11/13/2007	JB
CONSULTED WITH SCOTT BELIVEAU	11/15/2007	JB
EAST	6/3/2008	JB
EAST	6/4/2008	JB
EAST	2/3/2009	JB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/JONATHAN R BECKLEY/ Examiner.Art Unit 2625	
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<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

/JONATHAN R BECKLEY/ Examiner.Art Unit 2625	
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